

ESDAXLC4-1BF3

Single line extra low capacitance TVS

Features

- Stand-off voltage 3 V
- Ultra low capacitance 0.3 pF on a wide frequency spectrum, 200 to 3000 MHz
- Bidirectional device
- Low clamping factor V_{CL}/V_{BR}
- Fast response time
- Very thin package: 0.36 mm max
- Low leakage current

Complies with the following standards

■ IEC 61000-4-2 level 4

Applications

Where transient over voltage protection and electrical overstress protection in sensitive equipment is required, such as:

- Computers
- Printers
- Communication systems
- Cellular phone handsets and accessories
- Video equipment Portable equipment

Description

The ESDAXLC4-1BF3 is a single line Transil™ diode designed specifically for the protection of integrated circuits into portable equipment and miniaturized electronics devices subject to ESD and EOS transient over voltages.

Packaged in WLCSP, it minimizes PCB consumption.

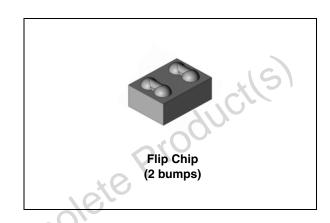
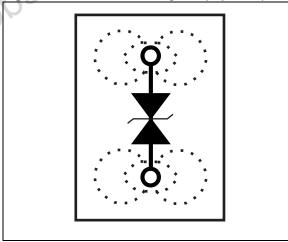


Figure 1. Schematic diagram (top view)



TM: Transil is a trademark of STMicroelectronics

Characteristics ESDAXLC4-1BF3

1 Characteristics

Table 1. Absolute maximum ratings ($T_{amb} = 25 \, ^{\circ}C$)

Symbol	Parameter			Unit
V _{PP}	Peak pulse voltage: IEC61000-4-2 contact discharge		8	kV
P _{PP}	Peak pulse power dissipation (8/20 µs) ⁽¹⁾ $T_{j initial} = T_{amb}$			W
I _{PP}	Repetitive peak pulse current (8/20 μs) $T_{j initial} = T_{amb}$			Α
T _j	Junction temperature			O°C
T _{stg}	Storage temperature range			°C
T _L	Maximum lead temperature for soldering during 10 s			°C

^{1.} For a surge greater than the maximum values, the diode will fail in short-circuit

Figure 2. Electrical characteristics (definitions)

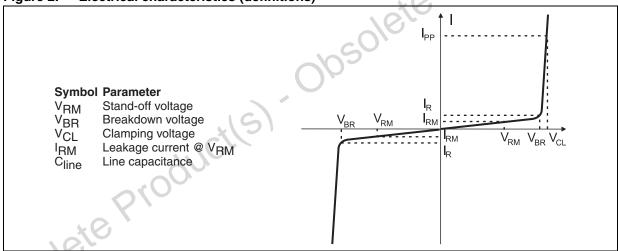


Table 2. Electrical characteristics (values, $T_{amb} = 25$ °C)

Symbol	Test condition	Min.	Тур.	Max.	Unit
V_{BR}	I _R = 1 mA	4	5.5	-	V
I _{RM}	V _{RM} = 3 V	-	-	50	nA
V _{CL}	I_{PP} (8/20 µs) = 1 A	-	-	10	٧
C _{line}	F = [200 MHz -3000] MHz, V_R = 0 V DC, V_{OSC} = 30 m V_{RMS}	•	0.3	0.4	pF

Doc ID 018522 Rev 2

ESDAXLC4-1BF3 Characteristics

Figure 3. Junction capacitance versus reverse applied voltage (typical values)

Figure 4. Junction capacitance versus frequencies (typical values)

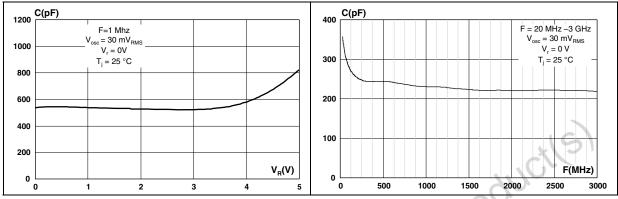


Figure 5. S_{21} attenuation measurement result Figure 6.

Variation of leakage current versus junction temperature (typical values)

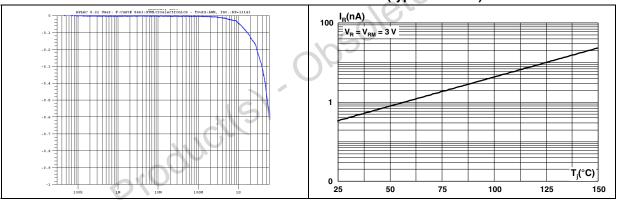
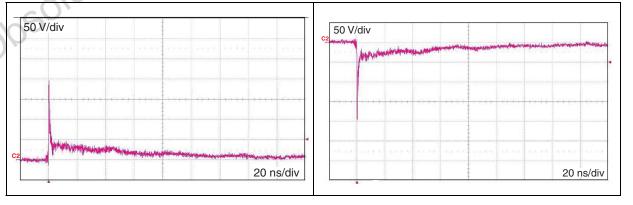


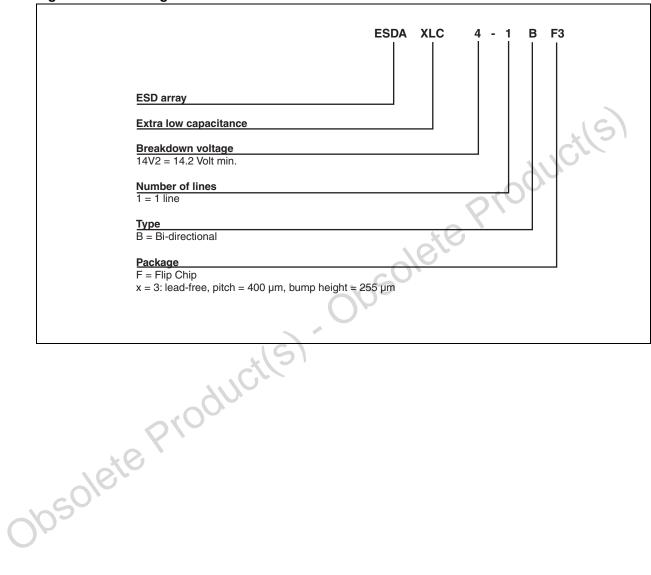
Figure 7. ESD response to IEC61000-4-2 (+8 kV contact discharge)

Figure 8. ESD response to IEC61000-4-2 (-8 kV contact discharge)



2 Ordering information scheme

Figure 9. Ordering information scheme



3 Package information

- Epoxy meets UL94,V0
- Lead-free package

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

Figure 10. Package dimensions

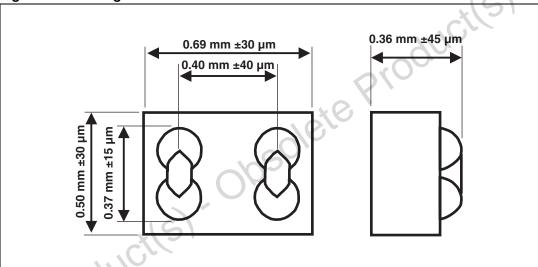
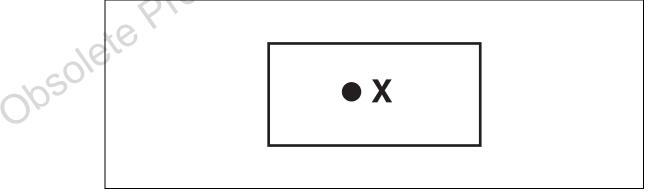


Figure 11. Marking



PCB recommendations ESDAXLC4-1BF3

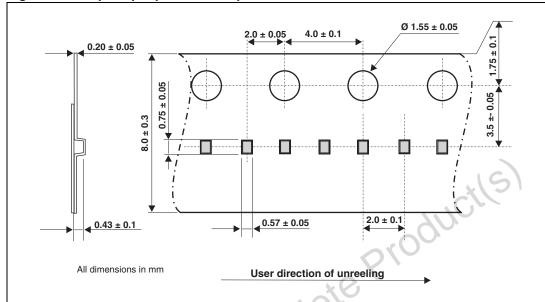


Figure 12. Flip Chip tape and reel specification

4 PCB recommendations

4.1 Design

For optimum electrical performance and highly reliable solder joints, STMicroelectronics recommends the PCB design recommendations listed in *Table 3*.

Table 3. PCB design recommendations for solder bar pitch 400 µm

For NSMD PCB	Oblong pad: 370 x 180 µm - Micro via SSBU allowed - Micro via SBU to be avoided - Micro via SBU filled (under qualification)
non solder mask defined	Track: - Only one track per pad - Maximum track width = 100 µm Track layout must be symmetrical to the die axis (to homogenize stress and welding attraction during reflow assembly)
For SMD PCB solder mask defined	Oblong pad: - Micro via SSBU allowed - Micro via SBU to be avoided - Micro via SBU filled (under qualification)
PCB Pad Finishing	Cu – Ni (2-6 μm) - Au (0.2 μm max)

Note:

A gold layer finishing on the PCB pad that is too thick (0.2 μ m maximum) is not recommended (low joint reliability).

6/10 Doc ID 018522 Rev 2

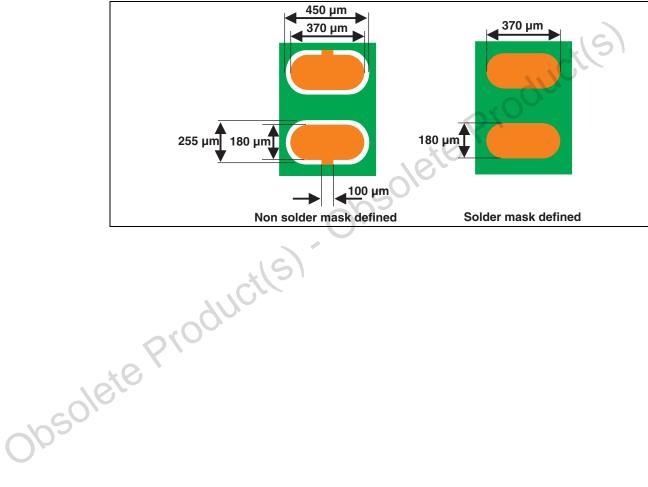
ESDAXLC4-1BF3 PCB recommendations

To optimize the natural self centering effect of CSP on the PCB, PCB pad positioning and size have to be properly designed (see *Figure 13*)

Micro vias

An alternative to routing on the top surface is to route out on buried layers. To achieve this, the pads are connected to the lower layers using micro vias. Only SSBU via technology is approved.

Figure 13. Solder mask opening



PCB recommendations ESDAXLC4-1BF3

4.2 Assembly

For chip scale package mounting on the PCB, STMicroelectronics recommends the use of a solder stencil aperture of 330 x 330 μ m² maximum and a typical stencil thickness of 75 or 80 μ m. Chip scale packages are fully compatible with the use of near eutectic 95.5 Sn, 4 Ag, 0.5 Cu solder paste with no-clean flux. ST's recommendations for chip scale package board mounting are illustrated on the soldering reflow profile shown in *Figure 14*.

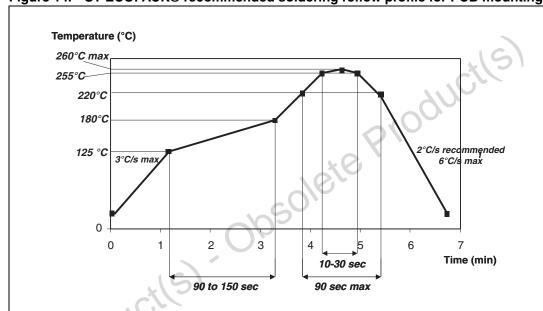


Figure 14. ST ECOPACK® recommended soldering reflow profile for PCB mounting

Dwell time in the soldering zone (with temperature higher than 220 °C) has to be kept as short as possible to prevent component and substrate damages. Peak temperature must not exceed 260 °C. Controlled atmosphere (N2 or N2H2) is recommended during the whole reflow, especially above 150 °C.

Chip scale packages are able to withstand three times the previous recommended reflow profile in order to be compatible with a double reflow when SMDs are mounted on both sides of the PCB and one additional repair.

A maximum of three soldering reflows are allowed for these lead-free packages (with repair step included).

The use of a no-clean flux is highly recommended to avoid any cleaning operation. To prevent any bump cracks, ultrasonic cleaning methods are not recommended.

8/10 Doc ID 018522 Rev 2

5 Ordering information

Table 4. Ordering information

Order code Marking		Package Weight		Base qty	Delivery mode	
ESDAXLC4-1BF3 L		Flip Chip	0.37 mg	15 000	Tape and reel 7"	

6 Revision history

Table 5. Document revision history

	Date	Revision	Changes
	03-Mar-2011	1	Initial release.
	12-May-2011	2	Updated features, Table 1, Figure 9 and Figure 11.
Obsole			Obsolet

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2011 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

10/10 Doc ID 018522 Rev 2